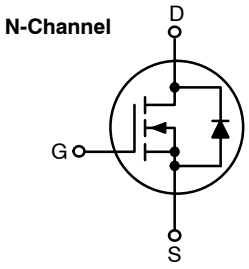
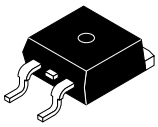
MOSFET – N-Channel, QFET

800 V, 3.9 A, 3.6 Ω

FQB4N80

V_{DS}	$R_{DS(ON)}$ MAX	I_D MAX
800 V	3.6 Ω @ 10 V	3.9 A





D²PAK-3
(TO-263, 3-LEAD)
CASE 418AJ

Description

This N-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. This device is suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 3.9 A, 800 V, $R_{DS(on)}$ = 3.6 Ω (Max.) @ V_{GS} = 10 V, I_D = 1.95 A
- Low Gate Charge (Typ. 19 nC)
- Low C_{rss} (Typ. 8.6 pF)
- 100% Avalanche Tested
- This Device is Pb-Free and Halide Free

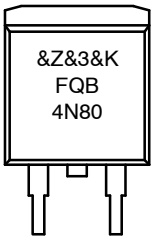
MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Symbol	Rating		Value	Unit
V_{DSS}	Drain-Source Voltage		800	V
I_D	Drain Current – Continuous (T_C = 25°C)		3.9	A
	– Continuous (T_C = 100°C)		2.47	
I_{DM}	Drain Current – Pulsed (Note 1)		15.6	A
V_{GSS}	Gate-Source Voltage		±30	V
E_{AS}	Single Pulsed Avalanche Energy (Note 2)		460	mJ
I_{AR}	Avalanche Current (Note 1)		3.9	A
E_{AR}	Repetitive Avalanche Energy (Note 1)		13	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.0	V/ns
P_D	Power Dissipation (T_A = 25°C)*		3.13	W
	Power Dissipation	(T_C = 25°C)	130	W
		– Derate above 25°C	1.04	W/°C
T_J, T_{STG}	Operating and Storage Temperature Range		–55 to +150	°C
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Repetitive rating: pulse-width limited by maximum junction temperature.
2. L = 57 mH, I_{AS} = 3.9 A, V_{DD} = 50 V, R_G = 25 Ω, starting T_J = 25°C.
3. I_{SD} ≤ 3.9 A, di/dt ≤ 200 A/μs, V_{DD} ≤ BV_{DSS}, starting T_J = 25°C.

MARKING DIAGRAMS



&Z	= Assembly Plant Code
&3	= 3-Digit Date Code Format
&K	= 2-Digits Lot Run Traceability Code
FQB4N80	= Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping†
FQB4N80TM	D²PAK-3	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.96	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (minimum pad of 2 oz copper), Max.	62.5	
	Thermal Resistance, Junction to Ambient (*1 in^2 pad of 2 oz copper), Max.	40	

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 μA	800	–	–	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C	–	0.95	–	V/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 800 V, V_{GS} = 0 V	–	–	10	μA
		V_{DS} = 640 V, T_C = 125°C	–	–	100	
I_{GSSF}	Gate-Body Leakage Current, Forward	V_{GS} = 30 V, V_{DS} = 0 V	–	–	100	nA
I_{GSSR}	Gate to Body Leakage Current, Reverse	V_{GS} = −30 V, V_{DS} = 0 V	–	–	−100	nA
ON CHARACTERISTICS						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 μA	3.0	–	5.0	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS} = 10 V, I_D = 1.95 A	–	2.8	3.6	Ω
g_{FS}	Forward Transconductance	V_{DS} = 50 V, I_D = 1.95 A	–	3.8	–	S
DYNAMIC CHARACTERISTICS						
C_{iss}	Input Capacitance	V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz	–	680	880	pF
C_{oss}	Output Capacitance		–	75	100	pF
C_{rss}	Reverse Transfer Capacitance		–	8.6	12	pF
SWITCHING CHARACTERISTICS						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 400 V, I_D = 3.9 A, R_G = 25 Ω (Note 4)	–	16	40	ns
t_r	Turn-On Rise Time		–	45	100	ns
$t_{d(off)}$	Turn-Off Delay Time		–	35	80	ns
t_f	Turn-Off Fall Time		–	35	80	ns
Q_g	Total Gate Charge	V_{DS} = 640 V, I_D = 3.9 A, V_{GS} = 10 V (Note 4)	–	19	25	nC
Q_{gs}	Gate-Source Charge		–	4.2	–	nC
Q_{gd}	Gate-Drain Charge		–	9.1	–	nC
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
I_S	Maximum Continuous Drain-Source Diode Forward Current		–	–	3.9	A
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current		–	–	15.6	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 3.9 A	–	–	1.4	V
t_{rr}	Reverse Recovery Time	V_{GS} = 0 V, I_S = 3.9 A, dI_F/dt = 100 A/μs	–	575	–	ns
Q_{rr}	Reverse Recovery Charge		–	3.65	–	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature typical characteristics.

TYPICAL CHARACTERISTICS

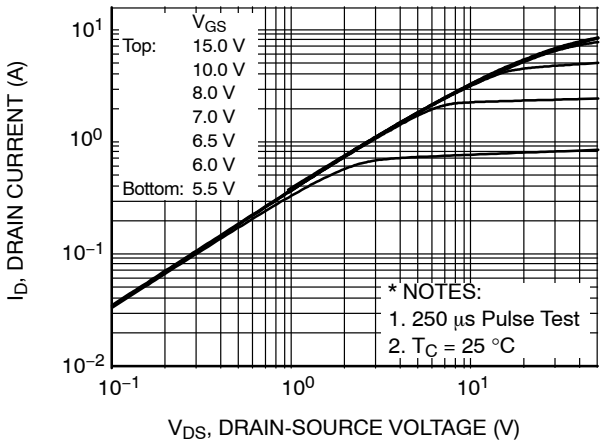


Figure 1. On-Region Characteristics

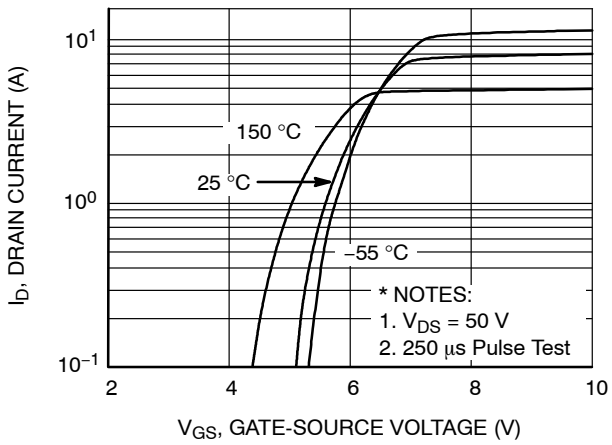


Figure 2. Transfer Characteristics

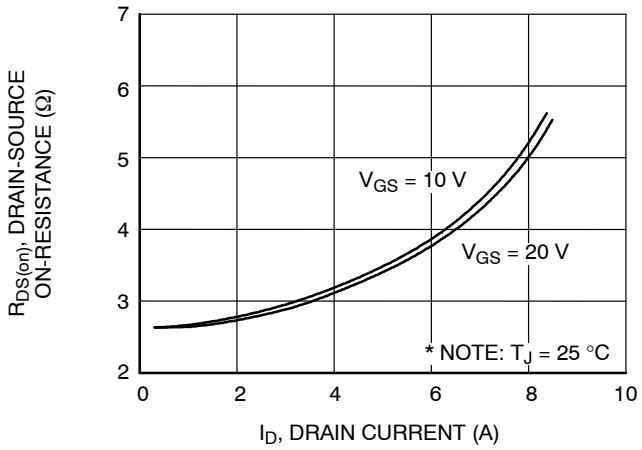


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

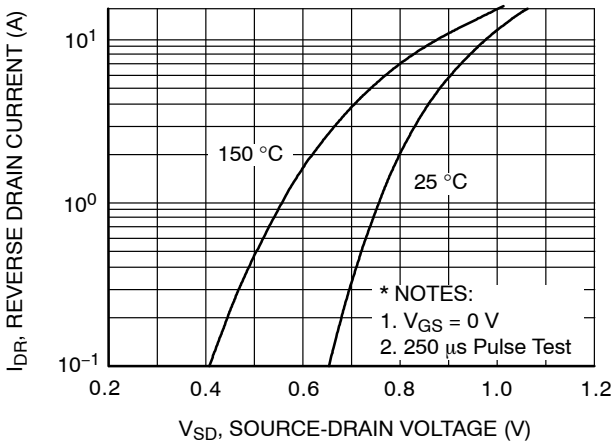


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

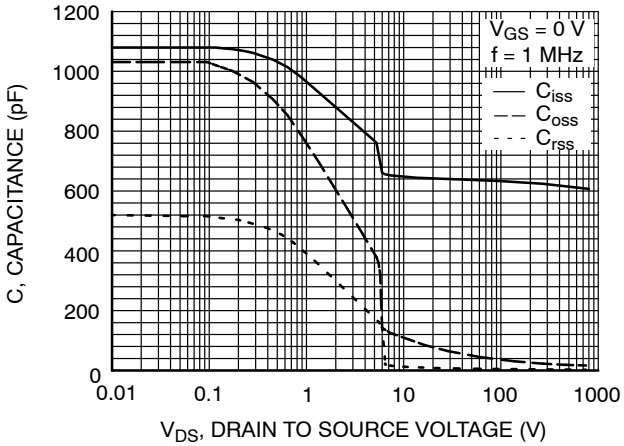


Figure 5. Capacitance Characteristics

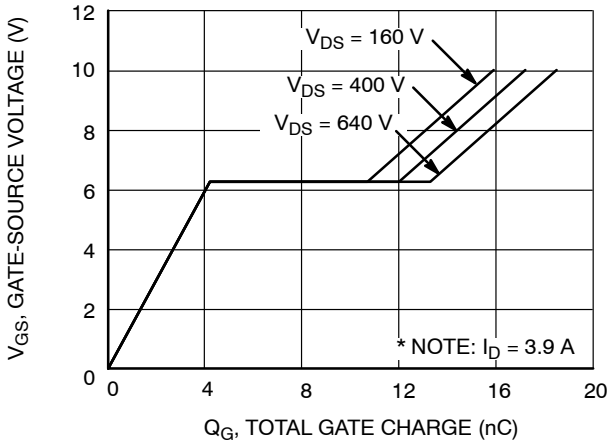


Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (continued)

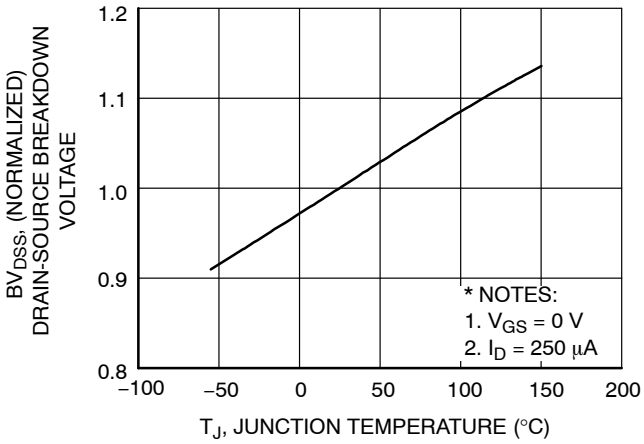


Figure 7. Breakdown Voltage Variation vs. Temperature

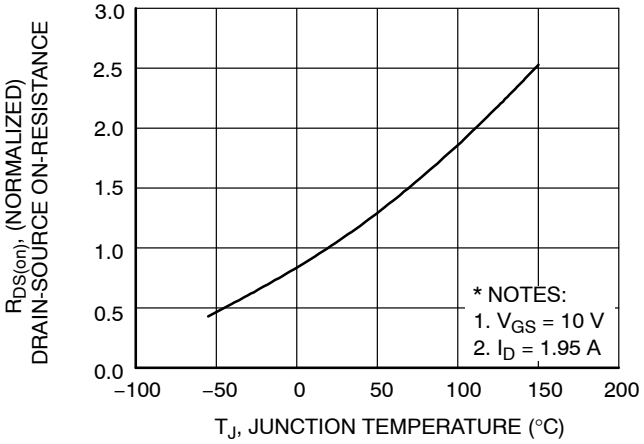


Figure 8. On-Resistance Variation vs. Temperature

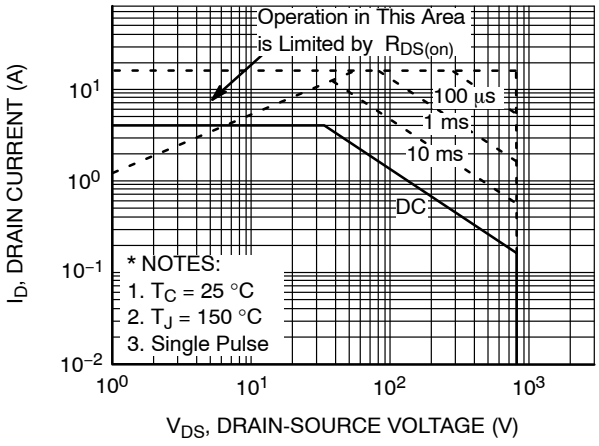


Figure 9. Maximum Safe Operating Area

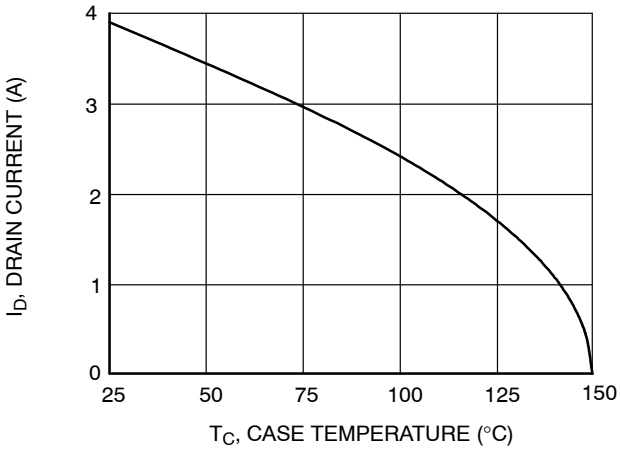


Figure 10. Maximum Drain Current vs. Case Temperature

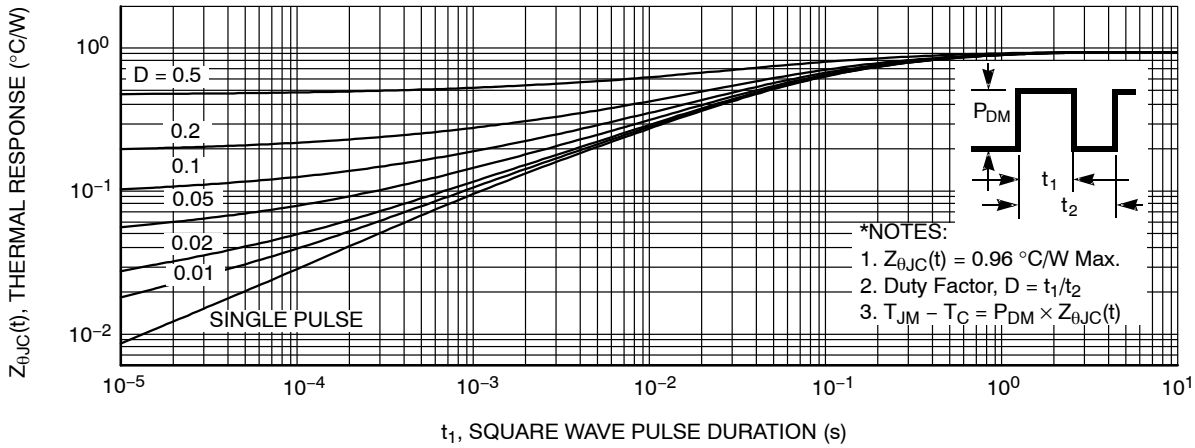


Figure 11. Transient Thermal Response Curve

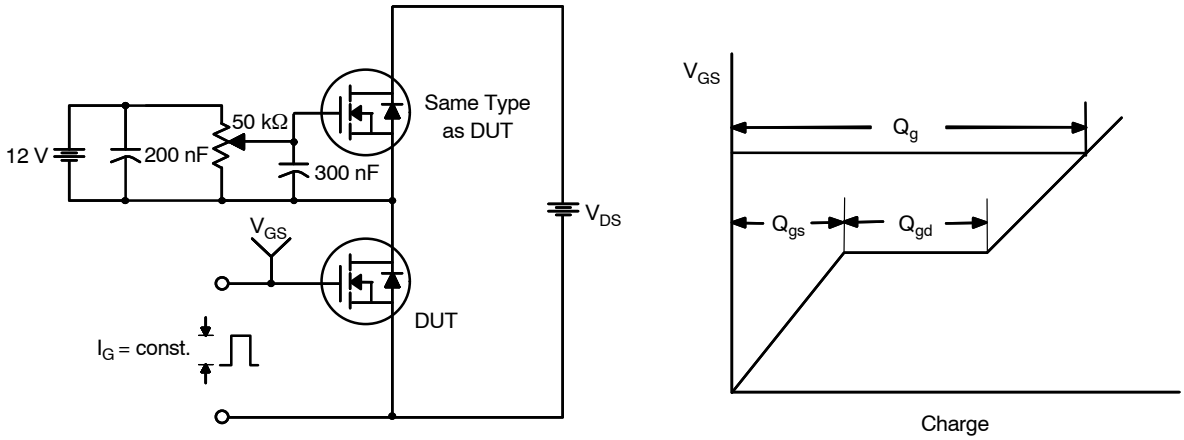


Figure 12. Gate Charge Test Circuit & Waveform

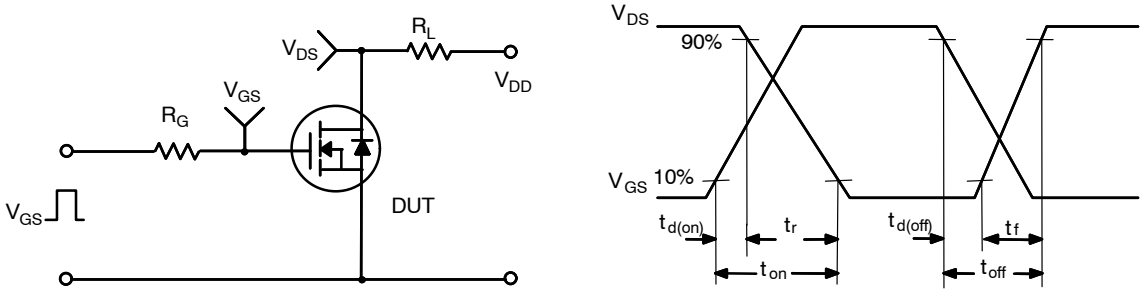


Figure 13. Resistive Switching Test Circuit & Waveforms

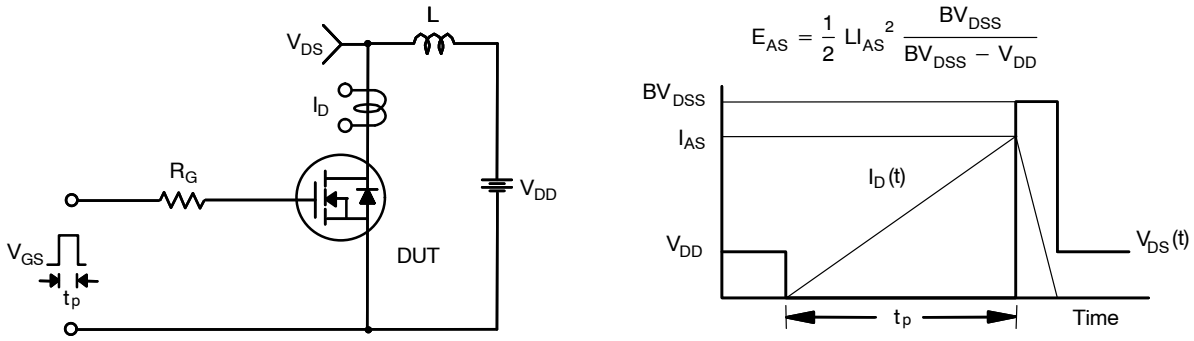


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

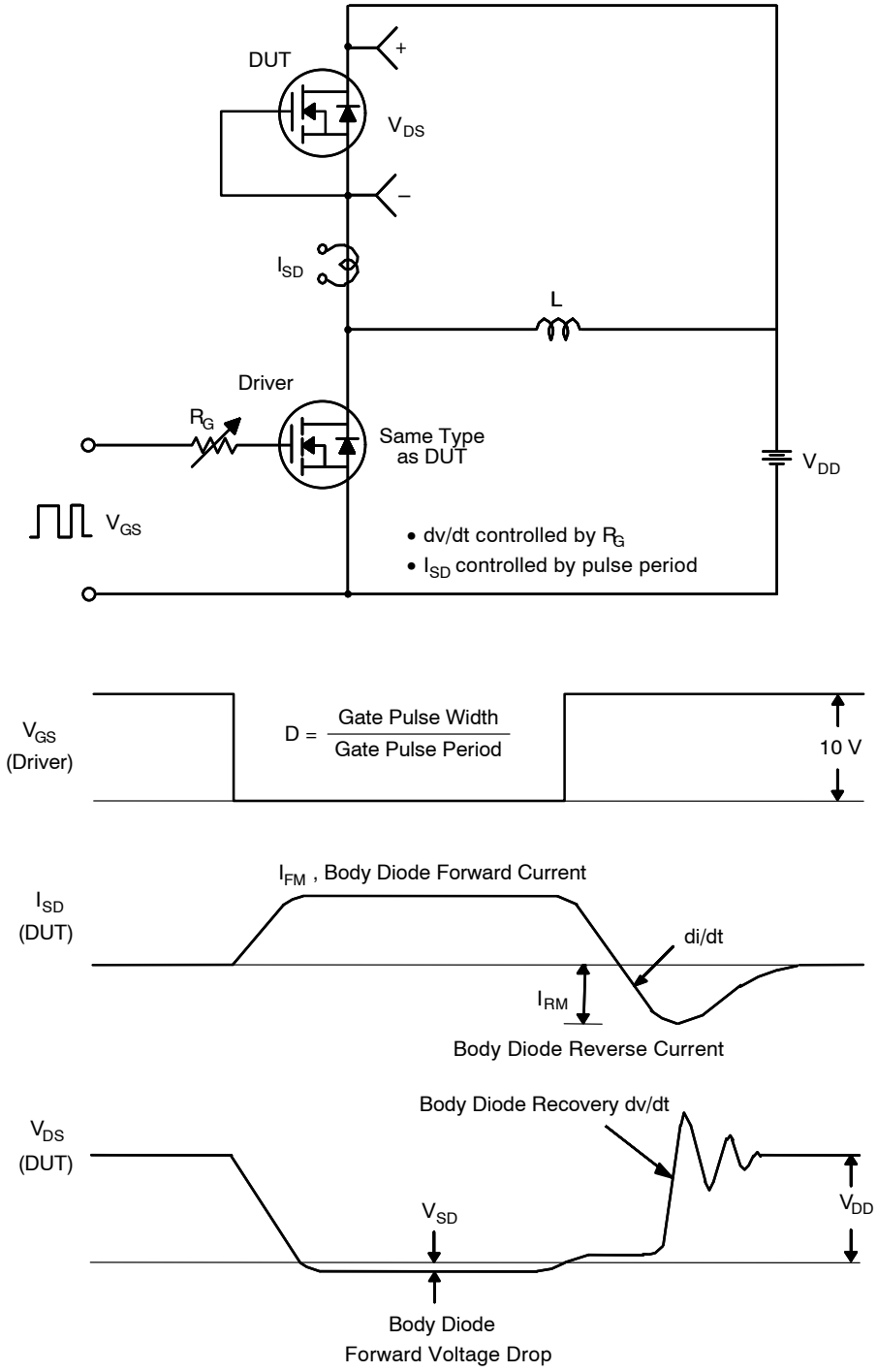


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

D²PAK–3 (TO–263, 3–LEAD)
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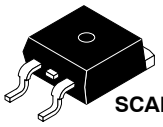
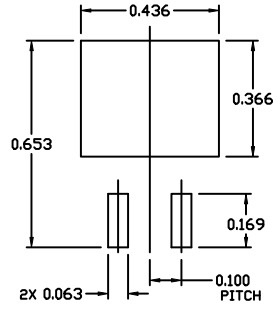
ISSUE F

DATE 11 MAR 2021



SCALE 1:1



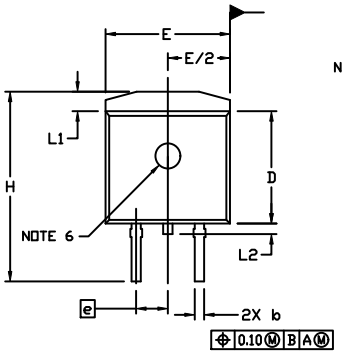
RECOMMENDED
MOUNTING FOOTPRINT

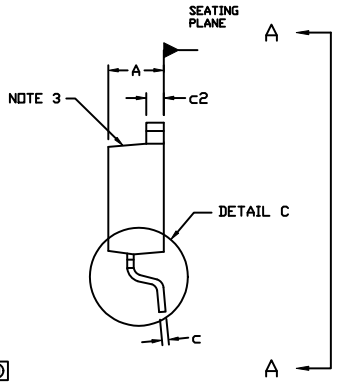
* For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

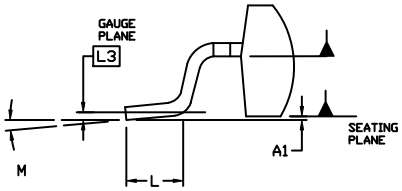
NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: INCHES
3. CHAMFER OPTIONAL.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
5. THERMAL PAD CONTOUR IS OPTIONAL WITHIN DIMENSIONS E, L1, D1, AND E1.
6. OPTIONAL MOLD FEATURE.
7. ①, ② … OPTIONAL CONSTRUCTION FEATURE CALL OUTS.

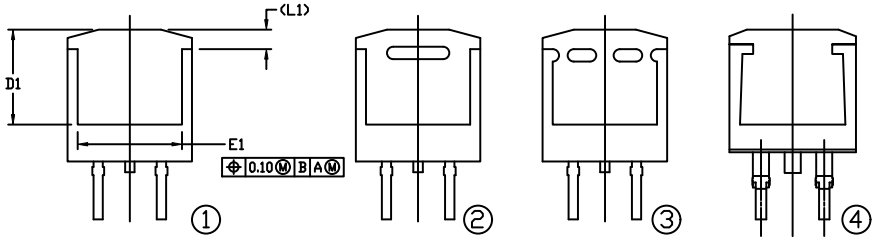
	INCHES		MILLIMETERS	
DIM	MIN.	MAX.	MIN.	MAX.
A	0.160	0.190	4.06	4.83
A1	0.000	0.010	0.00	0.25
b	0.020	0.039	0.51	0.99
c	0.012	0.029	0.30	0.74
c2	0.045	0.065	1.14	1.65
D	0.330	0.380	8.38	9.65
D1	0.260	---	6.60	---
E	0.380	0.420	9.65	10.67
E1	0.245	---	6.22	---
e	0.100 BSC		2.54 BSC	
H	0.575	0.625	14.60	15.88
L	0.070	0.110	1.78	2.79
L1	---	0.066	---	1.68
L2	---	0.070	---	1.78
L3	0.010 BSC		0.25 BSC	
M	0°	8°	0°	8°







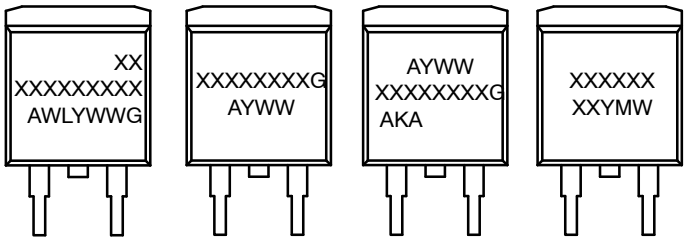
DETAIL C
TIP LEADFORM
ROTATED 90° CW



VIEW A–A

VIEW A–A
OPTIONAL CONSTRUCTIONS

GENERIC MARKING DIAGRAMS*



IC **Standard** **Rectifier** **SSG**

XXXXXX = Specific Device Code
A = Assembly Location
WL = Wafer Lot
Y = Year
WW = Work Week
W = Week Code (SSG)
M = Month Code (SSG)
G = Pb–Free Package
AKA = Polarity Indicator

*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, “G” or microdot “ ▪”, may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	**D²PAK–3 (TO–263, 3–LEAD)**	**PAGE 1 OF 1**

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